



# THE DATASHEET OF FDMA0104



**Single N-Channel 1.5 V Specified PowerTrench® MOSFET**  
**20 V, 9.4 A, 14.5 mΩ**

**Features**

- Max  $r_{DS(on)}$  = 14.5 mΩ at  $V_{GS} = 4.5$  V,  $I_D = 9.4$  A
- Max  $r_{DS(on)}$  = 18.2 mΩ at  $V_{GS} = 2.5$  V,  $I_D = 8.3$  A
- Max  $r_{DS(on)}$  = 23.3 mΩ at  $V_{GS} = 1.8$  V,  $I_D = 7.3$  A
- Max  $r_{DS(on)}$  = 32.3 mΩ at  $V_{GS} = 1.5$  V,  $I_D = 6.2$  A
- Low Profile-0.8 mm maximum in the new package MicroFET 2x2 mm
- RoHS Compliant

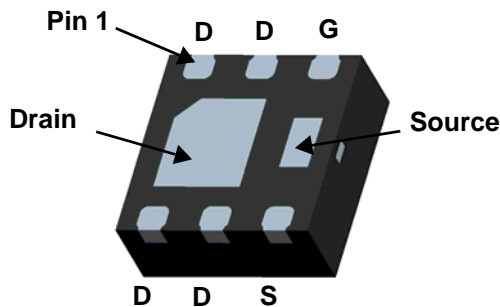


**General Description**

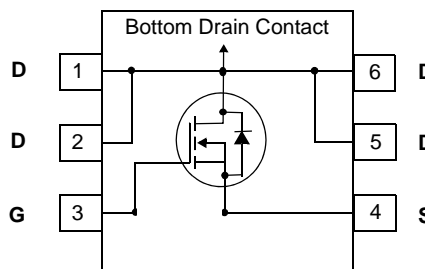
This Single N-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench® process to optimize the  $r_{DS(ON)}$  @  $V_{GS} = 1.5$  V on special MicroFET leadframe.

**Applications**

- Li-Ion Battery Pack
- DC-DC Buck Converters



**MicroFET 2X2 (Bottom View)**



**MOSFET Maximum Ratings**  $T_A = 25$  °C unless otherwise noted

| Symbol         | Parameter  | Ratings                 | Units |
|----------------|--|-------------------------|-------|
| $V_{DS}$       | Drain to Source Voltage                          | 20                      | V     |
| $V_{GS}$       | Gate to Source Voltage                           | ±8                      | V     |
| $I_D$          | -Continuous                                      | $T_A = 25$ °C (Note 1a) | 9.4   |
|                | -Pulsed  |                         | 54    |
| $P_D$          | Power Dissipation                                | $T_A = 25$ °C (Note 1a) | 1.9   |
|                | Power Dissipation                                | $T_A = 25$ °C (Note 1b) | 0.7   |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range | -55 to +150             | °C    |

**Thermal Characteristics**

|                 |   |           |     |      |
|-----------------|---|-----------|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 65  | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1b) | 180 |      |

**Package Marking and Ordering Information**

| Device Marking | Device   | Package      | Reel Size | Tape Width | Quantity   |
|----------------|----------|--------------|-----------|------------|------------|
| 104            | FDMA0104 | MicroFET 2X2 | 7 "       | 12 mm      | 3000 units |

**Electrical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

**Off Characteristics**

|                                      |   |   |    |    |           |                      |
|--------------------------------------|---|---|----|----|-----------|----------------------|
| $BV_{DSS}$                           | Drain to Source Breakdown Voltage         | $I_D = 250\text{ }\mu\text{A}$ , $V_{GS} = 0\text{ V}$                    | 20 |    |           | V                    |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$ |    | 15 |           | mV/ $^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = 16\text{ V}$ , $V_{GS} = 0\text{ V}$                            |    |    | 1         | $\mu\text{A}$        |
| $I_{GSS}$                            | Gate to Source Leakage Current            | $V_{GS} = \pm 8\text{ V}$ , $V_{DS} = 0\text{ V}$                         |    |    | $\pm 100$ | nA                   |

**On Characteristics**

|  |  |   |     |      |      |                      |
|--|--|---|-----|------|------|----------------------|
| $V_{GS(th)}$                           | Gate to Source Threshold Voltage                         | $V_{GS} = V_{DS}$ , $I_D = 250\text{ }\mu\text{A}$                                    | 0.4 | 0.6  | 1.0  | V                    |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$             |     | -3   |      | mV/ $^\circ\text{C}$ |
| $r_{DS(on)}$                           | Static Drain to Source On Resistance                     | $V_{GS} = 4.5\text{ V}$ , $I_D = 9.4\text{ A}$  |     | 11.3 | 14.5 | m $\Omega$           |
|  |  | $V_{GS} = 2.5\text{ V}$ , $I_D = 8.3\text{ A}$  |     | 12.7 | 18.2 |                      |
|  |  | $V_{GS} = 1.8\text{ V}$ , $I_D = 7.3\text{ A}$  |     | 15.0 | 23.3 |                      |
|  |  | $V_{GS} = 1.5\text{ V}$ , $I_D = 6.2\text{ A}$  |     | 18.3 | 32.3 |                      |
|  |  | $V_{GS} = 4.5\text{ V}$ , $I_D = 9.4\text{ A}$ ,<br>$T_J = 125\text{ }^\circ\text{C}$ |     | 14.7 | 18.3 |                      |
| $g_{FS}$                               | Forward Transconductance                                 | $V_{DD} = 5\text{ V}$ , $I_D = 9.4\text{ A}$  |     | 56   |      | S                    |

**Dynamic Characteristics**

|           |                              |  |  |      |      |          |
|-----------|------------------------------|--|--|------|------|----------|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 10\text{ V}$ , $V_{GS} = 0\text{ V}$ ,<br>$f = 1\text{ MHz}$ |  | 1260 | 1680 | pF       |
| $C_{oss}$ | Output Capacitance           |  |  | 180  | 240  | pF       |
| $C_{rss}$ | Reverse Transfer Capacitance |  |  | 122  | 185  | pF       |
| $R_g$     | Gate Resistance              |  |  | 1.9  |      | $\Omega$ |

**Switching Characteristics**

|              |                               |  |  |      |      |    |    |
|--------------|-------------------------------|--|--|------|------|----|----|
| $t_{d(on)}$  | Turn-On Delay Time            | $V_{DD} = 10\text{ V}$ , $I_D = 9.4\text{ A}$ ,<br>$V_{GS} = 4.5\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$ |  | 9    | 17   | ns |    |
| $t_r$        | Rise Time                     |  |  | 6    | 11   | ns |    |
| $t_{d(off)}$ | Turn-Off Delay Time           |  |  | 37   | 58   | ns |    |
| $t_f$        | Fall Time                     |  |  | 6    | 11   | ns |    |
| $Q_g$        | Total Gate Charge             |  | $V_{GS} = 0\text{ V to } 4.5\text{ V}$           |      | 17.5 |    | nC |
|              | Total Gate Charge             | $V_{GS} = 0\text{ V to } 2.5\text{ V}$   |  | 10.0 |      | nC |    |
|              | Total Gate Charge             | $V_{GS} = 0\text{ V to } 1.8\text{ V}$   | $V_{DD} = 10\text{ V}$ ,<br>$I_D = 9.4\text{ A}$ |      | 7.4  |    | nC |
|              | Total Gate Charge             | $V_{GS} = 0\text{ V to } 1.5\text{ V}$   |  |      | 6.2  |    | nC |
| $Q_{gs}$     | Gate to Source Charge         |  |  | 1.7  |      | nC |    |
| $Q_{gd}$     | Gate to Drain "Miller" Charge |  |  | 2.7  |      | nC |    |

**Drain-Source Diode Characteristics**

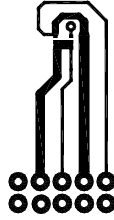
|          |   |   |  |      |     |    |
|----------|---|---|--|------|-----|----|
| $I_S$    | Maximum Continuous Drain-Source Diode Forward Current |   |  | 2.0  |     | A  |
| $V_{SD}$ | Source to Drain Diode Forward Voltage                 | $V_{GS} = 0\text{ V}$ , $I_S = 2.0\text{ A}$ (Note 2)     |  | 0.63 | 1.2 | V  |
| $t_{rr}$ | Reverse Recovery Time                                 | $I_F = 9.4\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ |  | 16   | 29  | ns |
| $Q_{rr}$ | Reverse Recovery Charge                               |   |  | 5    | 10  | nC |

NOTES:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



a. 65 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b. 180 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted

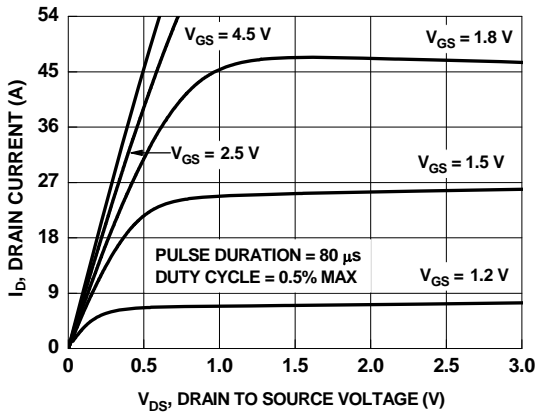


Figure 1. On Region Characteristics

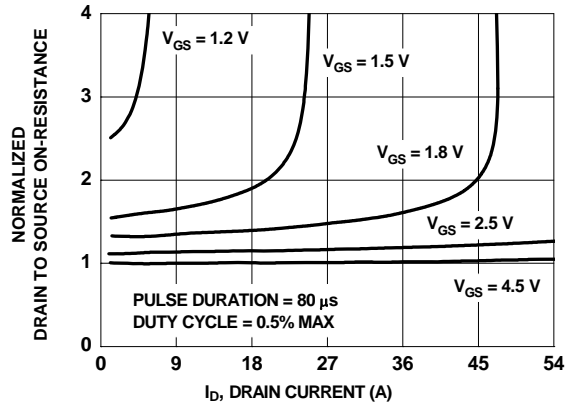


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

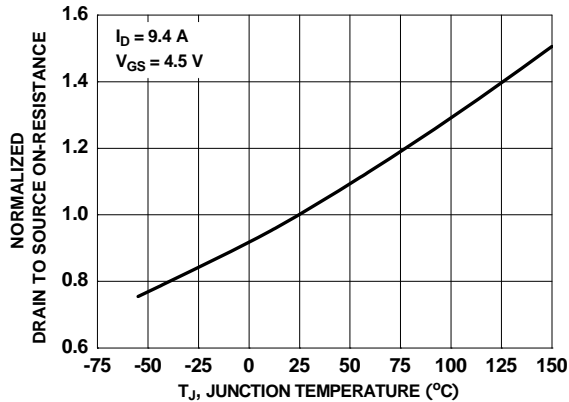


Figure 3. Normalized On Resistance vs Junction Temperature

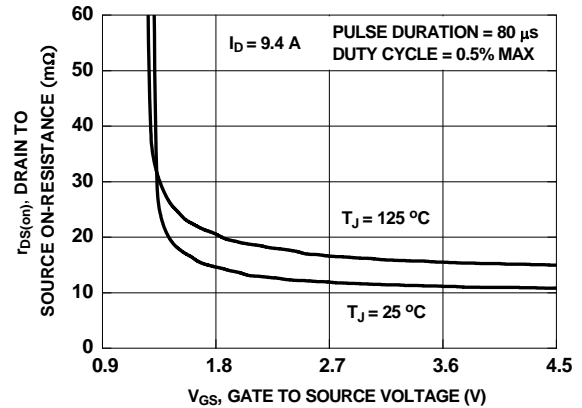


Figure 4. On-Resistance vs Gate to Source Voltage

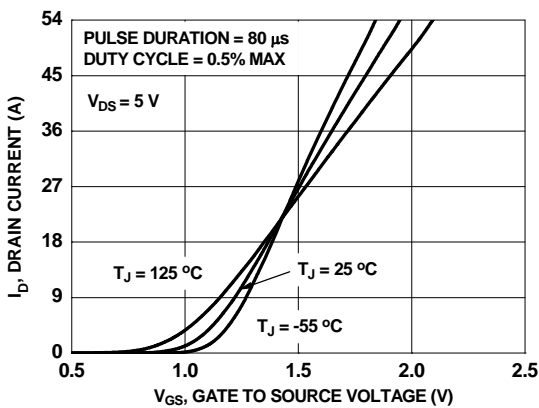


Figure 5. Transfer Characteristics

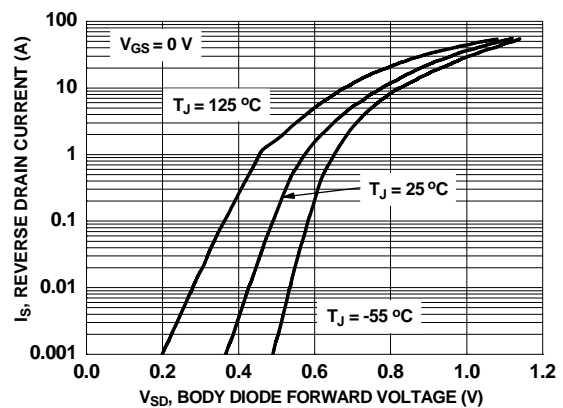
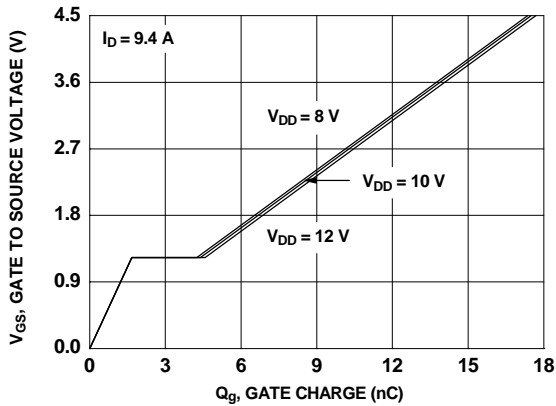
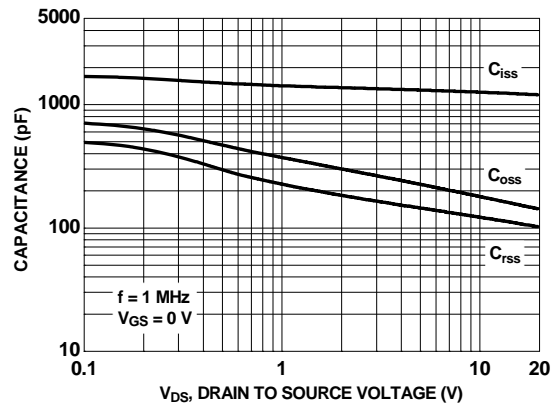


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

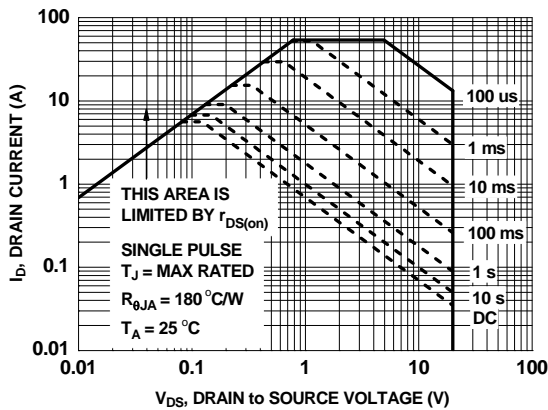
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



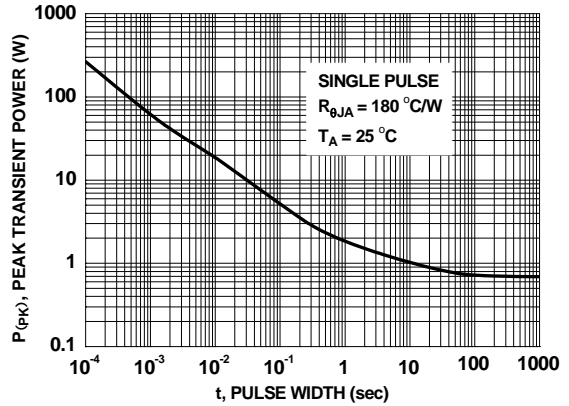
**Figure 7. Gate Charge Characteristics**



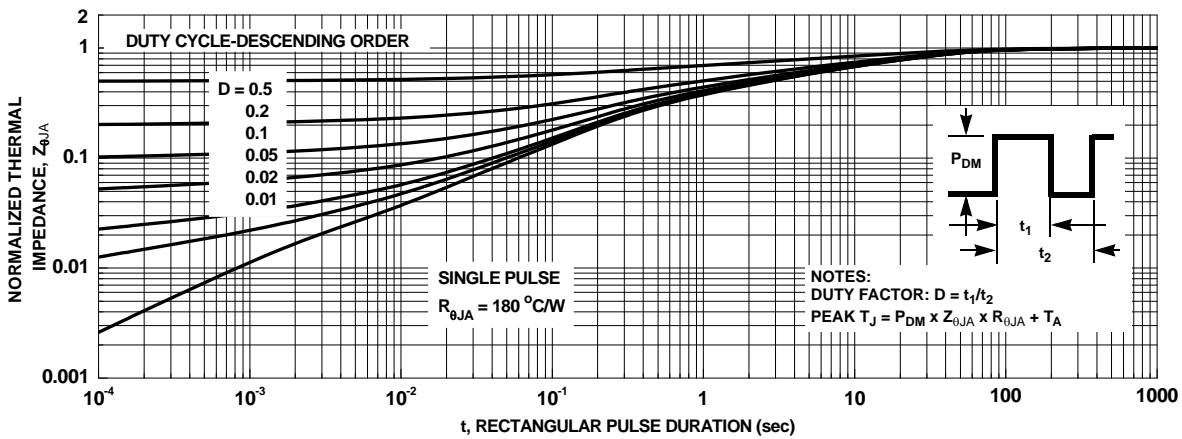
**Figure 8. Capacitance vs Drain to Source Voltage**



**Figure 9. Forward Bias Safe Operating Area**

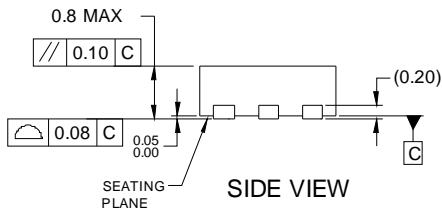
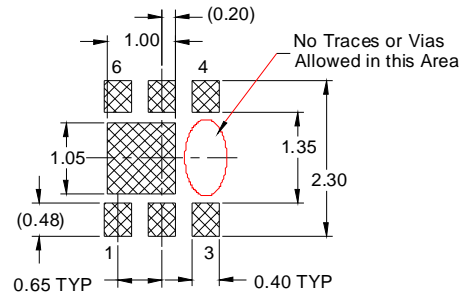
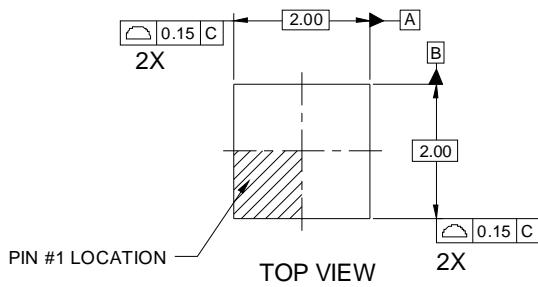


**Figure 10. Single Pulse Maximum Power Dissipation**

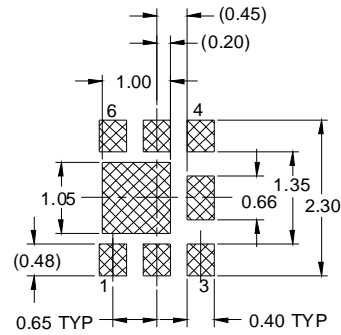
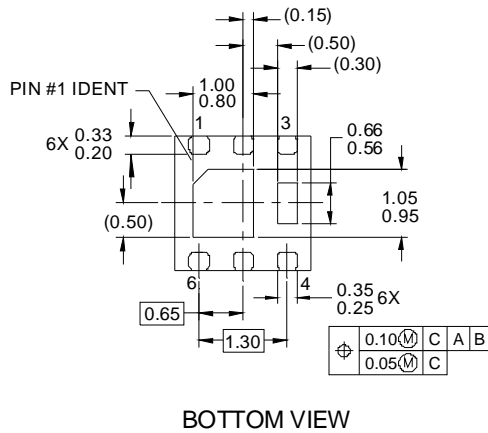


**Figure 11. Junction-to-Ambient Transient Thermal Response Curve**

## Dimensional Outline and Pad Layout



RECOMMENDED LAND PATTERN OPT 1



RECOMMENDED LAND PATTERN OPT 2






### NOTES:

- A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-229 DATED AUG/2003
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994



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